

| | | | |
|-----------------------------------|---------------------------------------|---------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 10/726,876 | Applicant(s)/Patent Under Reexamination KADOWAKI ET AL. | |
| | Examiner Yuzhen Ge | Art Unit 2624 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-------------------------|----------------|
| * | A | US-6,141,453 | 10-2000 | Banham et al. | 382/240 |
| * | B | US-6,661,927 b1 | 12-2003 | Suarez et al. | 382/240 |
| * | C | US-7,076,104 b1 | 07-2006 | Keith et al. | 382/233 |
| * | D | US-7,006,576 b1 | 02-2006 | Hannuksela, Miska | 375/240.27 |
| * | E | US-6,339,658 b1 | 01-2002 | Moccagatta et al. | 382/240 |
| * | F | US-6,778,709 | 08-2004 | Taubman, David S. | 382/240 |
| * | G | US-6,023,563 | 02-2000 | Shani, Ron | 709/249 |
| * | H | US-5,416,604 | 05-1995 | Park, Goo-man | 382/232 |
| * | I | US-5,959,981 | 09-1999 | Bruckert et al. | 370/331 |
| * | J | US-7,136,532 b2 | 11-2006 | Van Der Schaar, Mihaela | 382/233 |
| * | K | US-6,014,473 | 01-2000 | Hossack et al. | 382/294 |
| * | L | US-6,756,921 b2 | 06-2004 | Kimura et al. | 341/50 |
| * | M | US-6,031,939 | 02-2000 | Gilbert et al. | 382/239 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------------------------------|
| | U | Sections 6-7, Annex D.5, J.7 and J.14, ISO/IEC 15444-1, 1st Edition, 2000-12-15, hereafter referred to as 15444-1 |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.